

# **TEST REPORT**

**APPLICANT**: Entel PCS Telecomunicaciones S.A.

**PRODUCT NAME**: Smartphone

MODEL NAME : Smart 9

BRAND NAME : ÖWN

**STANDARD(S)** : 47 CFR Part 15 Subpart B

**TEST DATE** : 2018-06-28 to 2018-06-29

**ISSUE DATE** : 2018-07-09

Tested by:

Wu Zhongwen (Test, Engineer)

Approved by:

Andy Yeh(Technical Director)

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## **DIRECTORY**

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| Change History |            |                   |  |  |  |
|----------------|------------|-------------------|--|--|--|
| Issue          | Date       | Reason for change |  |  |  |
| 1.0            | 2018-07-09 | First edition     |  |  |  |
|                |            |                   |  |  |  |



## 1. Technical Information

Note: Provide by applicant.

## 1.1. Applicant and Manufacturer Information

| Applicant:            | Entel PCS Telecomunicaciones S.A.                                 |  |
|-----------------------|---|--|
| Applicant Address:    | Costanera Sur 2760, Torre C, Piso 18, las condes, Santiago, Chile |  |
| Manufacturer:         | Shenzhen Tinno Mobile Technology Corp.                            |  |
| Manufacturer Address: | 4/F.,H-3 Building,OCT Eastern Industrial Park. NO.1 XiangShan     |  |
|                       | East Road.,Nan Shan District,Shenzhen,P.R.China.                  |  |

## 1.2. Equipment Under Test (EUT) Description

| EUT Type:         | Smartphone                          |
|-------------------|-------------------------------------|
| Serial No:        | (N/A, marked #1 by test site)       |
| Hardware Version: | V1.0                                |
| Software Version: | OWN_SMART_9_8.0                     |
| Tx Frequency:     | GSM850: 824 MHz ~ 849 MHz           |
|                   | GSM1900: 1850 MHz ~ 1910 MHz        |
|                   | WCDMA Band II: 1850MHz ~ 1910 MHz   |
|                   | WCDMA Band IV: 1710MHz ~ 1755 MHz   |
|                   | WCDMA Band V: 824MHz ~ 849 MHz      |
|                   | LTE Band 2: 1850 MHz ~ 1910 MHz     |
|                   | LTE Band 4: 1710 MHz ~ 1755 MHz     |
|                   | LTE Band 7: 2500 MHz ~ 2570 MHz     |
|                   | Bluetooth: 2402 MHz ~ 2480 MHz      |
|                   | 802.11b/g/n-20: 2412 MHz ~ 2462 MHz |
|                   | 802.11n-40: 2422 MHz ~ 2452 MHz     |
| Rx Frequency:     | GSM850: 869 MHz ~ 894 MHz           |
|                   | GSM1900: 1930 MHz ~ 1990 MHz        |
|                   | WCDMA Band II: 1930MHz ~ 1990 MHz   |
|                   | WCDMA Band IV: 2110MHz ~ 2155 MHz   |
|                   | WCDMA Band V: 869MHz ~ 894 MHz      |
|                   | LTE Band 2: 1930MHz ~ 1990MHz       |
|                   | LTE Band 4: 2110 MHz ~ 2115 MHz     |
|                   | LTE Band 7: 2620 MHz ~ 2690 MHz     |
|                   | Bluetooth: 2402 MHz ~ 2480 MHz      |
|                   | 802.11b/g/n-20: 2412 MHz ~ 2462 MHz |
|                   | 802.11n-40: 2422 MHz ~ 2452 MHz     |





| Ancillary         | Battery        |                               |
|-------------------|----------------|-------------------------------|
| <b>Equipment:</b> | Brand Name:    | ÖWN                           |
|                   | Model No.:     | N/A                           |
|                   | Serial No.:    | (N/A, marked #1 by test site) |
|                   | Capacity:      | 3000mAh                       |
|                   | Rated Voltage: | 3.85V                         |
|                   | Charge Limit:  | 4.4V                          |
|                   | AC Adapter 1   |                               |
|                   | Brand Name:    | ÖWN                           |
|                   | Model No.:     | TN-050155U1                   |
|                   | Serial No.:    | (N/A, marked #1 by test site) |
|                   | Rated Input:   | ~ 100-240V, 50/60Hz,0.25A     |
|                   | Rated Output:  | =5V,1.55A                     |
|                   | AC Adapter 2   |                               |
|                   | Brand Name:    | ÖWN                           |
|                   | Model No.:     | TN-050155E1                   |
|                   | Serial No.:    | (N/A, marked #1 by test site) |
|                   | Rated Input:   | ~ 100-240V, 50/60Hz,0.25A     |
|                   | Rated Output:  | =5V,1.55A                     |

#### Note:

- The Smartphone supports GSM850MHz, 1900MHz, GPRS, EDGE, WCDMA Band II, Band
   IV, Band V, LTE Band 2/4/7, Bluetooth band, WIFI (802.11b/g/n) band.
- 2. There are two types of adapters, they have the same internal circuit, only differ in the plug shape and model name. And the American adapter (TN-050155U1) is used in the United States, the European standard adapter (TN-050155E1) is used in Europe and Chile, only the case (TN-050155U1) is recorded in this report.
- 3. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer



2. Test Results

# 2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

| No. | Identity       | Document Title          |  |  |
|-----|----------------|-------------------------|--|--|
| 1   | 47 CFR Part 15 | Radio Frequency Devices |  |  |

Test detailed items/section required by FCC rules and results are as below:

| No. | Section | Description        | Test Date Test Engineer |             | Result |
|-----|---------|--------------------|-------------------------|-------------|--------|
| 1   | 15.107  | Conducted Emission | 2018.06.28              | Wu Zhongwen | PASS   |
| 2   | 15.109  | Radiated Emission  | 2018.06.29              | Wu Zhongwen | PASS   |

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.



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## 2.2. EUT Setup and Operating Conditions

Frequency range was investigated: Conducted emission test: from 150 KHz to 30 MHz; Radiated emission test: from 30 MHz to 6000 MHz.

| Test Item | est Item   |  |  |  |  |  |
|-----------|--|--|--|--|--|--|
| Radiated  | Radiated Emission  |  |  |  |  |  |
| Mode 1    | EUT + USB Line + PC + Battery + Earphones  |  |  |  |  |  |
| Mode 2    | Mode 2 EUT + Adapter + Earphones   |  |  |  |  |  |
| Conducte  | ed Emission  |  |  |  |  |  |
| Mode 1    | EUT + USB Line + PC + Battery + Earphones  |  |  |  |  |  |
| Mode 2    | EUT + Adapter + Earphones  |  |  |  |  |  |
| Remark:   | Remark:  |  |  |  |  |  |
| The above | e test modes in boldface were the worst cases of conducted emission, radiated emission |  |  |  |  |  |

tests; only the test data of these modes was reported.

During the measurement, the environmental conditions were within the listed ranges:

| Temperature (°C):           | 15 - 35  |
|-----------------------------|----------|
| Relative Humidity (%):      | 30 - 60  |
| Atmospheric Pressure (kPa): | 86 - 106 |





# 3. 47 CFR Part 15B Requirements

## 3.1. Conducted Emission

#### 3.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a  $50\mu H/50\Omega$  line impedance stabilization network (LISN).

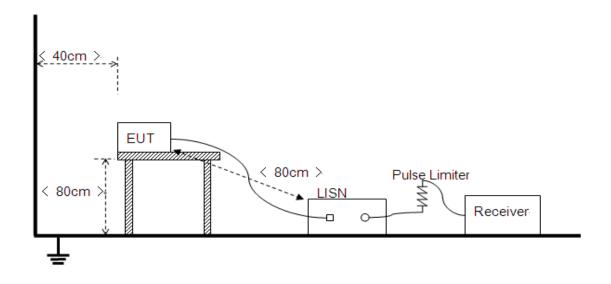
| Frequency range | Conducted Limit (dBµV) |          |  |
|-----------------|------------------------|----------|--|
| (MHz)           | Quasi-peak             | Average  |  |
| 0.15 - 0.50     | 66 to 56               | 56 to 46 |  |
| 0.50 - 5        | 56                     | 46       |  |
| 5 - 30          | 60                     | 50       |  |

#### NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

#### 3.1.2. Test Setup

Please refer to Annex A for the photographs of the Test Configuration.



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The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides  $50\Omega/50\mu H$  of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

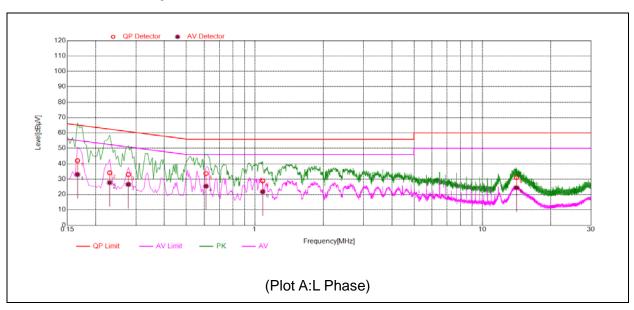
The power strip or extension cord has been investigated to make sure that the LISN integrity in maintained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

#### 3.1.3. Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

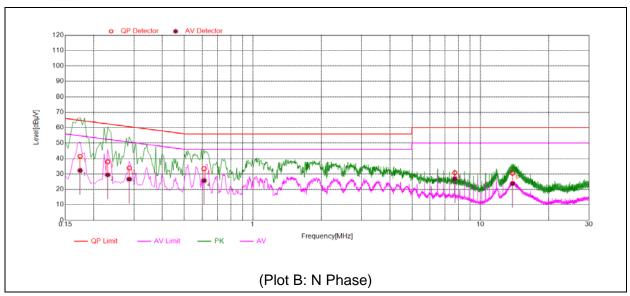


## A. Test Plot and Suspicious Points:



| NO. | Fre.   | Emission Lo | evel (dBµV) | Limit (d  | dΒμV)   | Power-line | Verdict |
|-----|--------|-------------|-------------|-----------|---------|------------|---------|
| NO. | (MHz)  | Quai-peak   | Average     | Quai-peak | Average | Power-line | verdict |
| 1   | 0.1659 | 41.91       | 33.01       | 65.16     | 55.16   |            | PASS    |
| 2   | 0.2299 | 34.13       | 27.74       | 62.45     | 52.45   | Line       | PASS    |
| 3   | 0.2778 | 32.95       | 26.55       | 60.88     | 50.88   |            | PASS    |
| 4   | 0.6097 | 33.63       | 25.47       | 56.00     | 46.00   |            | PASS    |
| 5   | 1.0815 | 28.80       | 21.77       | 56.00     | 46.00   |            | PASS    |
| 6   | 14.109 | 31.06       | 24.42       | 60.00     | 50.00   |            | PASS    |





| NO. | Fre.<br>(MHz) | Emission Lo | evel (dBµV) | Limit (d  | dΒμV)   | Dower line | Vordiot |
|-----|---------------|-------------|-------------|-----------|---------|------------|---------|
| NO. |               | Quai-peak   | Average     | Quai-peak | Average | Power-line | Verdict |
| 1   | 0.1739        | 41.43       | 32.28       | 64.77     | 54.77   |            | PASS    |
| 2   | 0.2300        | 37.85       | 29.41       | 62.45     | 52.45   | Neutral    | PASS    |
| 3   | 0.2858        | 33.86       | 26.59       | 60.64     | 50.64   |            | PASS    |
| 4   | 0.6097        | 33.44       | 25.64       | 56.00     | 46.00   |            | PASS    |
| 5   | 7.7198        | 30.71       | 26.90       | 60.00     | 50.00   |            | PASS    |
| 6   | 13.840        | 30.50       | 23.79       | 60.00     | 50.00   |            | PASS    |



### 3.2. Radiated Disturbance

#### 3.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

| Frequency     | Field Strength Limitation at 3m Measurement Dist |           |  |  |
|---------------|--|-----------|--|--|
| range (MHz)   | (μV/m) (dBμV/m)                                  |           |  |  |
| 30.0 - 88.0   | 100  | 20log 100 |  |  |
| 88.0 - 216.0  | 150  | 20log 150 |  |  |
| 216.0 - 960.0 | 200  | 20log 200 |  |  |
| Above 960.0   | 500  | 20log 500 |  |  |

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

#### Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- Limitation expressed in dBμV/m is calculated by 20log Emission Level(μV/m).

### 3.2.2. Frequency range of measurement

According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the following table:

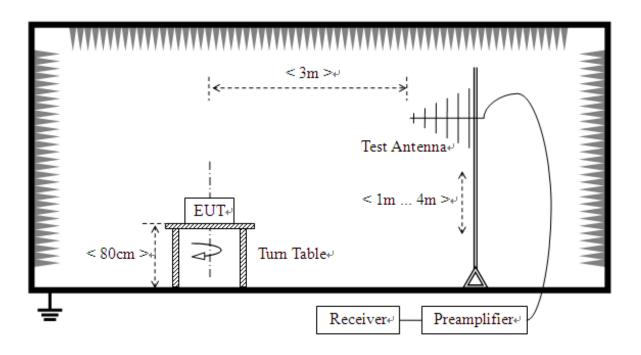
| Highest frequency generated<br>or used in the device or on<br>which the device operates or<br>tunes (MHz) | Upper frequency of measure-<br>ment range (MHz)  |
|---|--|
| Below 1.705   | 30.<br>1000.<br>2000.<br>5000.<br>5th harmonic of the highest<br>frequency or 40 GHz,<br>whichever is lower. |



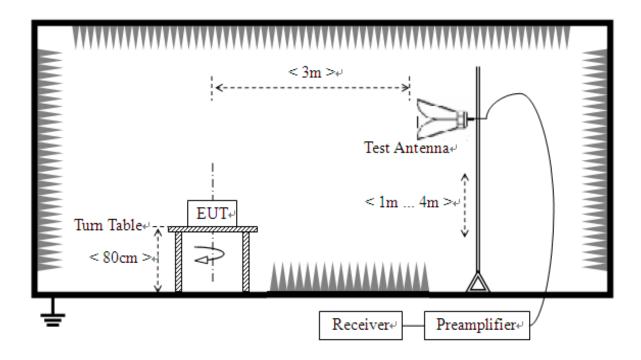


### 3.2.3. Test Setup

1) For radiated emissions from 30MHz to1GHz



2) For radiated emissions above 1GHz







The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on avariable-height antenna master tower.

#### For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

#### 3.2.4. Test Result

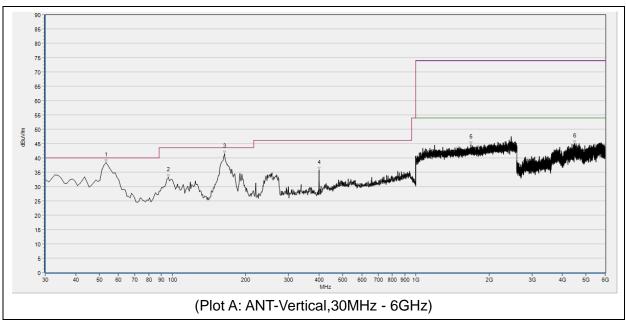
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of emissions (6GHz-12.5GHz) which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

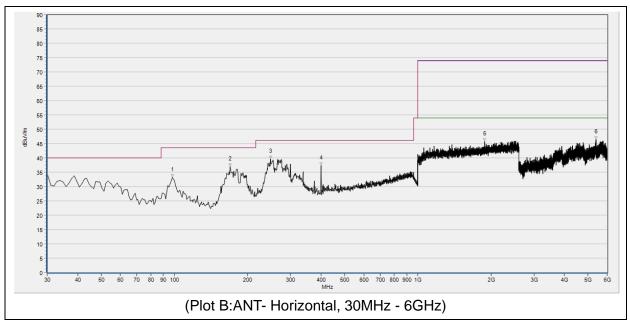






| No. | Fre.<br>MHz | Pk<br>dBµV/m | QP<br>dBµV/m | AV<br>dBμV/m | Limit-PK<br>dBµV/m | Limit-QP<br>dBµV/m | Limit-AV<br>dBµV/m | ANT      | Verdict |
|-----|-------------|--------------|--------------|--------------|--------------------|--------------------|--------------------|----------|---------|
| 1   | 53.220      | 38.73        | 35.42        | N.A.         | N.A.               | 40.00              | N.A.               | <b>V</b> | PASS    |
| 2   | 95.960      | 33.21        | N.A.         | N.A.         | N.A.               | 43.50              | N.A.               | <b>V</b> | PASS    |
| 3   | 163.860     | 41.47        | N.A.         | N.A.         | N.A.               | 43.50              | N.A.               | V        | PASS    |
| 4   | 399.570     | 35.73        | N.A.         | N.A.         | N.A.               | 46.00              | N.A.               | V        | PASS    |
| 5   | 1682.133    | 44.71        | N.A.         | N.A.         | 74.00              | N.A.               | 54.00              | <b>V</b> | PASS    |
| 6   | 4484.960    | 44.95        | N.A.         | N.A.         | 74.00              | N.A.               | 54.00              | V        | PASS    |



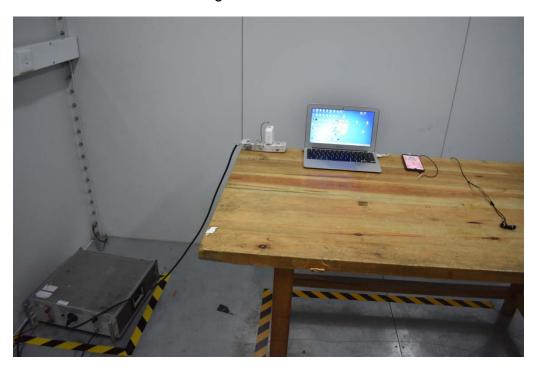


| No. | Fre.<br>MHz | Pk<br>dBµV/m | QP<br>dBµV/m | AV<br>dBμV/m | Limit-PK<br>dBµV/m | Limit-QP<br>dBµV/m | Limit-AV<br>dBµV/m | ANT | Verdict |
|-----|-------------|--------------|--------------|--------------|--------------------|--------------------|--------------------|-----|---------|
| 1   | 97.900      | 33.25        | N.A.         | N.A.         | N.A.               | 43.50              | N.A.               | Н   | PASS    |
| 2   | 169.680     | 36.92        | N.A.         | N.A.         | N.A.               | 43.50              | N.A.               | Н   | PASS    |
| 3   | 248.250     | 39.62        | N.A.         | N.A.         | N.A.               | 46.00              | N.A.               | Н   | PASS    |
| 4   | 399.570     | 37.29        | N.A.         | N.A.         | N.A.               | 46.00              | N.A.               | Н   | PASS    |
| 5   | 1881.067    | 45.65        | N.A.         | N.A.         | 74.00              | N.A.               | 54.00              | Н   | PASS    |
| 6   | 5387.320    | 46.45        | N.A.         | N.A.         | 74.00              | N.A.               | 54.00              | Н   | PASS    |

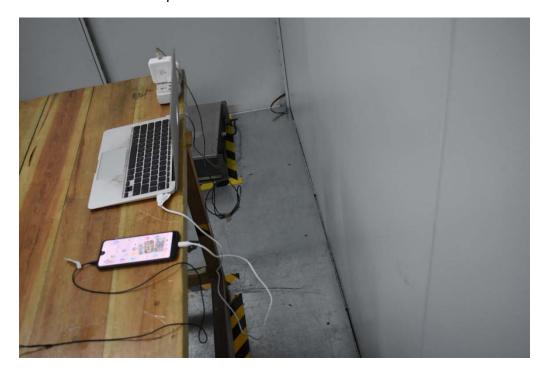


# **Annex A Photographs of Test Setup**

1. Mains Terminal Disturbance Voltage Measurement

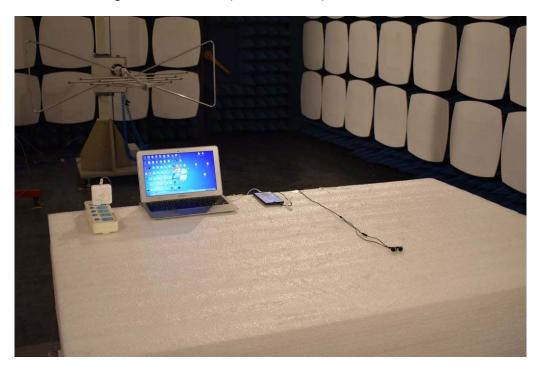


2. Conducted emission main's port side view

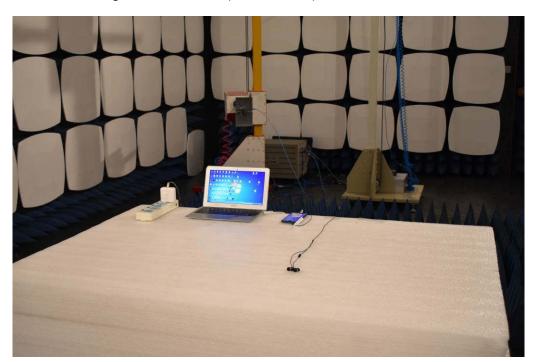




## 3. Radiated Field Strength Measurement(30MHz-1GHz)



## 4. Radiated Field Strength Measurement(above 1GHz)





# **Annex B Test Uncertainty**

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

### Uncertainty of Conducted Emission Measurement

| Measuring Uncertainty for | 9kHz-150kHz  | ±4.1 dB |
|---------------------------|--------------|---------|
| a Level of Confidence of  | 150kHz-30MHz | ±3.7dB  |
| 95%(U=2Uc(y))             |              |         |

#### Uncertainty of Radiated Emission Measurement

| Measuring Uncertainty for | 30MHz-200MHz   | ±5.06dB |
|---------------------------|----------------|---------|
| a Level of Confidence of  | 200MHz-1000MHz | ±5.24dB |
| 95%(U=2Uc(y))             | 1GHz-6GHz      | ±5.18dB |
|                           | 6GHz-18GHz     | ±5.48dB |





# **Annex C Testing Laboratory Information**

### 1. Identification of the Responsible Testing Laboratory

| Company Name:        | Shenzhen Morlab Communications Technology Co., Ltd.   |  |  |  |
|----------------------|---|--|--|--|
| Department:          | Morlab Laboratory                                     |  |  |  |
| Address:             | FL.3, Building A, FeiYang Science Park, No.8 LongChar |  |  |  |
|                      | Road, Block 67, BaoAn District, ShenZhen, GuangDon    |  |  |  |
|                      | Province, P. R. China                                 |  |  |  |
| Responsible Test Lab | Mr. Su Feng   |  |  |  |
| Manager:             |   |  |  |  |
| Telephone:           | +86 755 36698555                                      |  |  |  |
| Facsimile:           | +86 755 36698525                                      |  |  |  |

### 2. Identification of the Responsible Testing Location

| Name:    | Shenzhen Morlab Communications Technology Co., Ltd.    |
|----------|--|
| Name.    | Morlab Laboratory                                      |
|          | FL.3, Building A, FeiYang Science Park, No.8 LongChang |
| Address: | Road, Block 67, BaoAn District, ShenZhen, GuangDong    |
|          | Province, P. R. China                                  |

#### 3. Accreditation Certificate

| Accredited Testing | The FCC designation number is CN1192.                 |
|--------------------|---|
| Laboratory:        | (Shenzhen Morlab Communications Technology Co., Ltd.) |

#### 4. Test Software Utilized

| Model            | Version Number | Producer |
|------------------|----------------|----------|
| MORLAB EMCR V1.2 | Version 1.0    | MORLAB   |
| TS+ -[ JS32-CE]  | Version2.5.0.0 | Tonscend |





## 5. Test Equipments Utilized

| Description              | Manufacturer | Model       | Serial No. | Cal. Date  | Due. Date  |
|--------------------------|--------------|-------------|------------|------------|------------|
| MXE EMI<br>Receiver      | Agilent      | N9038A      | MY54130016 | 2018.05.08 | 2019.05.07 |
| Receiver                 | KEYSIGHT     | N9038A      | MY56400093 | 2017.07.13 | 2018.07.12 |
| LISN                     | Schwarzbeck  | NSLK 8127   | 812744     | 2018.05.08 | 2019.05.07 |
| Pulse Limiter<br>(20dB)  | VTSD         | 9561D       | 9537       | 2018.05.08 | 2019.05.07 |
| Test Antenna -<br>Bi-Log | Schwarzbeck  | VULB 9163   | 9163-519   | 2018.05.08 | 2019.05.07 |
| Test Antenna -<br>Horn   | Schwarzbeck  | BBHA 9120D  | 1774       | 2017.09.13 | 2018.09.12 |
| Semi-Anechoic<br>Chamber | CRT          | 9m*6m*6m 2# | N/A        | 2017.01.12 | 2020.01.11 |

| END OF REPORT |  |
|---------------|--|
|---------------|--|